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Duran, O.; Althoefer, K.; Seneviratne, L.D.;

Mechatronics, IEEE/ASME Transactions on , Volume: 8 , Issue: 3 , Sept. 2003
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Whitehorn, M.; Vincent, T.; Debrunner, C.H.; Steele, J.;

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4 MISR in-flight camera geometric model calibration and georectification performance

Jovanovic, V.M.; Bull, M.A.; Smyth, M.M.; Jia Zong;

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Pages:1512 - 1519

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Bruegge, C.J.; Chrien, N.L.; Ando, R.R.; Diner, D.J.; Abdou, W.A.; Helmlinger, M.C.; Pilorz, S.H.; Thome, K.J.;

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Chrien, N.L.; Bruegge, C.J.; Ando, R.R.;

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Nister, D.;

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2 Uncalibrated Euclidean 3-D reconstruction using an active vision system
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